

<b>Notice of References Cited</b>	Application/Control No. 10/788,566	Applicant(s)/Patent Under Reexamination VITTITOE, NEAL F.	
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	M	US-			

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**NON-PATENT DOCUMENTS**

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	U	Joyce E. Farrell, "Print Quality Metrics for Grayscale Text", 1990, In Proceedings of the SPSE Fifth International Congress on Non-Impact Printing Technologies
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.